

Hit-and-Run Crashes: Use of Rough Set Analysis with Logistic Regression to Capture Critical Attributes and Determinants

Kim K, Pant P, Yamashita E.
Transportation research record
2008; 2083:114-121

ARTICLE IDENTIFIERS

DOI: 10.3141/2083-13
PMID: unavailable
PMCID: not available

JOURNAL IDENTIFIERS

LCCN: 74032372
pISSN: 0361-1981
eISSN: 2169-4052
OCLC ID: 01259379
CONS ID: not available
US National Library of Medicine ID: 101481512

This article was identified from a query of the SafetyLit database.